

PCN Number: CO-22556 Date Issued: March 5th, 2019 PCN Effective Date: March 5th, 2019	Contact: Elizabeth La Greca Title: Director, Sales Operations Phone: 1-858-795-0106			
Product(s) Affected: PE42543	Email: pcn@psemi.com			
Sample Availability: March 5th, 2019				
Change Control Board Approval #: CO-22556				
Change Category:				
Wafer Fabrication Process	Shipping/Labeling			
Design/Mask Change	Equipment			
Singulation Process	Material			
Assembly Process - New package laminate	Product Specification			
Electrical Test	Product End of Life			
Manufacturing Site	Other - Ordering codes change			

### **Purpose of Change:**

To enable usage of Lapis in Japan as the wafer fabrication site, SEMCO in Korea for PCB substrate supply and Unisem in Malaysia as the primary assembly/test site for the PE42543.

### **Description of Change:**

This is a notification to advise our customers that pSemi is transferring PE42543 for the following reasons.

- 1) Wafer fab transfer to Lapis as MagnaChip closed their 150mm wafer CMOS fab in South Korea at the end of 2015. To ensure continuity of supply, pSemi has been working to transfer products from MagnaChip fab to Lapis fab in Japan. Lapis is a qualified pSemi fab.
- 2) Assembly/test transfer to Unisem as Amkor has discontinued their assembly tooling for this product. Unisem in Malaysia is pSemi's qualified assembly/test house for FCLGA package.
- Laminate supplier is discontinuing current production process (electroless NiAu ENIG) laminate plating finish and transitioning to an industry standard (electroless NiPdAu - ENEPIG). pSemi is making this transition to assure ongoing laminate supply with improved solderability and reliability.
- 4) ESD Rating: 2500V to 2000V HBM on all pins (Class 2).
- 5) Insertion Loss @ 13.5GHz~16GHz Max limit from 3.2 to 3.6 dB @ 16GHz~18GHz Max limit from 3.9 to 4.7 dB

Beginning <u>March 5th, 2019</u>, the PE42543 shipped to customers will be supplied from Lapis wafers. Lapis will be the wafer fabrication site and Unisem will be the Assembly/Test site for the PE42543 using ENEPIG substrate.

PE42543 material has been qualified with no change to fit or reliability.



Ordering code changes: Original ordering codes (MagnaChip): PE42543A-X; EK42543-02 New ordering codes (Lapis+Unisem with new PCB substrate): PE42543B-X; EK42543-03

pSemi manages inventory on a First-In First-Out (FIFO) basis. For the exact timing of the order code change, please contact your account rep. or <u>accountrep@psemi.com</u>.

### **Customer Acknowledgement of Receipt:**

Change Denied (Include explanation in	Name:	
comments section below)	Title:	
Change Approved	Company:	
	Date:	
	Signature:	
Customer Comments:		



Appendix A – Reliability Qualification Summary



**Reliability Summary Report** 

**PE42543** 

Part Number(s):	PE42543	Product Family:	RF Switch
Package Type:	29L 4x4 FCLGA	MSL Rating:	MSL 3
Technology Platform:	ULTRACMOS <sup>®</sup> 5		
Reliability Summary:	Based on the results of reliability testing, the PE42543 has met the reliability requirements for Production.		

#### Table 1: Product Design Reliability Results

Test #	Test Performed	TEST METHOD/ Conditions	Duration	Sample Size	Result
1	High Temperature Operating Life (HTOL)	JESD22-A108; VDD= 5.5V; VCTL= 3.6 V; T <sub>A</sub> = T <sub>J</sub> = 125 °C;	1000 Hrs.	1 lot x 77	Pass
2	ESD Human Body Model (HBM)	MIL-STD-883 3015.7 (All pins)	2kV	1 lot x 3	Pass
3	ESD Machine Model (MM)	JEDEC JESD22-A115	150V	1 x 3	Pass
4	ESD Charged Device Model (CDM)	JEDEC JESD22-C101	500V	1 x 3	Pass

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# PE42543

**Reliability Summary Report** 

#### Table 2: Package Reliability Results

Test	Test Performed	TEST METHOD/ Conditions	Duration	Sample Size	Result
5	High Temperature Storage Life (HTSL)	JESD22-A103; T <sub>a</sub> = 150°C	1,000 hrs.	3 lots x 45	Pass
6	Moisture Sensitivity Level (MSL3)	JESD22-A113/J-STD- 020 Moisture Soak at 30°C/ 60% RH. Reflow at 260°C.	192 hrs. 3x Reflow	3 x 15	Pass
7	Highly Accelerated Stress Test (HAST)	JESD22-A110; T <sub>A</sub> = 110°C; RH= 85%; VDD= 3.55 V	264 hrs.	3 x 45	Pass
8	Temperature Cycling (TC)	JESD22-A104; T <sub>A</sub> = -55°C to +125°C	1,000 cycs.	3 x 45	Pass
9	Physical Dimensions	JESD22-B100 / Subcon specs.	-	3 lots x 10 Devices	Pass
10	Die Shear	Mil-Std-883 M2019.8 / Subcon specs.	-	3 lots x 5 Devices	Pass
11	Solderability	JESD22-B102 / Subcon specs.	-	3 lots x 5 Devices	Pass

Technology Reliability Report (DOC-81028)

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